

Notice of References Cited	Application/Control No. 10/729,722	Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner Emmanuel Bayard	Art Unit 2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0019042	01-2005	Kaneda et al.	398/208
*	B	US-2002/0159544	10-2002	Karaoguz, Jeyhan	375/329
*	C	US-2002/0159543	10-2002	Perlow et al.	375/324
*	D	US-2005/0053129	03-2005	Yousef, Nabil R.	375/233
*	E	US-7,113,540	09-2006	Yousef et al.	375/233
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.